







SN74LV1T125

SCLS745C - DECEMBER 2013 - REVISED OCTOBER 2023

SN74LV1T125 Single Power Supply Single Buffer Gate with 3-State Output CMOS **Logic Level Shifter**

1 Features

- Single-supply voltage translator at 5-V, 3.3-V, 2.5-V, and 1.8-V V_{CC}
- Operating range of 1.8 V to 5.5 V
- Up translation:
 - 1.2 V⁽¹⁾ to 1.8 V at 1.8-V V_{CC}
 - 1.5 V⁽¹⁾ to 2.5 V at 2.5-V V_{CC}
 - 1.8 V⁽¹⁾ to 3.3 V at 3.3-V V_{CC}
 - 3.3 V to 5.0 V at 5.0-V V_{CC}
- Down translation:
 - 3.3 V to 1.8 V at 1.8-V V_{CC}
 - 3.3 V to 2.5 V at 2.5-V V_{CC}
 - 5.0 V to 3.3 V at 3.3-V V_{CC}
- Logic output is referenced to V_{CC}
- Output drive:
 - 8.0 mA output drive at 5 V
 - 7.0 mA output drive at 3.3 V
 - 3.0 mA output drive at 1.8 V
- Characterized up to 50 MHz at 3.3-V V_{CC}
- 5.0 V Tolerance on input pins
- -40°C to 125°C operating temperature range
- Latch-Up Performance Exceeds 250 mAPer JESD 17

- Supports standard logic pinouts
- CMOS output B compatible with AUP1G and LVC1G families 1

2 Applications

- **Telecom**
- Portable applications
- Servers
- PC and notebooks

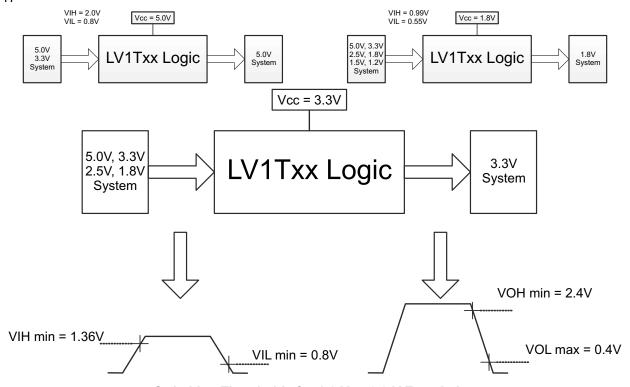
3 Description

The SN74LV1T125 is a single buffer gate with reduced input thresholds to support voltage translation applications.

Package Information

| PART NUMBER | PACKAGE ⁽¹⁾ | PACKAGE SIZE(2) | BODY SIZE(3) |
|-------------|------------------------|------------------|-----------------|
| SN74LV1T125 | DBV (SOT-23, 5) | 2.90 mm × 2.8 mm | 2.9 mm x 1.6 mm |
| | DCK (SC70, 5) | 2.00 mm × 2.1 mm | 2 mm × 1.25 mm |

- For all available packages, see the orderable addendum at the end of the data sheet.
- The package size (length × width) is a nominal value and (2) includes pins, where applicable.
- (3) The body size (length x width) is a nominal value and does not include pins.



Switching Thresholds for 1.8-V to 3.3-V Translation

¹ Refer to the V_{IH}/V_{IL} and output drive for lower V_{CC} condition.



Table of Contents

| 1 Features1 | 9 Detailed Description10 |
|---------------------------------------|---|
| 2 Applications1 | |
| 3 Description1 | 9.2 Functional Block Diagram10 |
| 4 Revision History2 | |
| 5 Related Products3 | 9.4 Device Functional Modes13 |
| 6 Pin Configuration and Functions4 | 10 Application Information Disclaimer14 |
| 7 Specifications5 | 10.1 Layout14 |
| 7.1 Absolute Maximum Ratings5 | 10.2 Power Supply Recommendations14 |
| 7.2 ESD Ratings5 | 11 Device and Documentation Support15 |
| 7.3 Recommended Operating Conditions5 | 11.1 Receiving Notification of Documentation Updates 15 |
| 7.4 Thermal Information6 | 11.2 Support Resources15 |
| 7.5 Electrical Characteristics6 | 11.3 Trademarks15 |
| 7.6 Switching Characteristics7 | 11.4 Electrostatic Discharge Caution15 |
| 7.7 Operating Characteristics7 | |
| 7.8 Typical Characteristics8 | 12 Mechanical, Packaging, and Orderable |
| 8 Parameter Measurement Information9 | Information15 |
| | |
| | |
| | |

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| | · · · · · · · · · · · · · · · · · · · | |
|---|---|-------|
| C | Changes from Revision B (June 2022) to Revision C (October 2023) | Page |
| • | Updated Package Information table | 1 |
| • | Updated RθJA values: DCK = 252 to 289.2, all values in °C/W | 6 |
| C | Changes from Revision A (February 2014) to Revision B (June 2022) | Page |
| • | Updated the numbering format for tables, figures, and cross-references throughout the document | 1 |
| • | Added ESD Ratings table, Thermal Information table, Typical Characteristics section, Pin Configuratio | n and |
| | Functions section, Detailed Description section, Power Supply Recommendations section, Layout sec | tion, |
| | Receiving Notification of Documentation Updates section, and Community Resources section | 5 |
| • | Added Typical Characteristics | 8 |



5 Related Products

| DEVICE | PACKAGE | DESCRIPTION |
|-------------|----------|--|
| SN74LV1T00 | DCK, DBV | 2-Input Positive-NAND Gate |
| SN74LV1T02 | DCK, DBV | 2-Input Positive-NOR Gate |
| SN74LV1T04 | DCK, DBV | Inverter Gate |
| SN74LV1T08 | DCK, DBV | 2-Input Positive-AND Gate |
| SN74LV1T17 | DCK, DBV | Single Schmitt-Trigger Buffer Gate |
| SN74LV1T14 | DCK, DBV | Single Schmitt-Trigger Inverter Gate |
| SN74LV1T32 | DCK, DBV | 2-Input Positive-OR Gate |
| SN74LV1T34 | DCK, DBV | Single Buffer Gate |
| SN74LV1T86 | DCK, DBV | Single 2-Input Exclusive-Or Gate |
| SN74LV1T125 | DCK, DBV | Single Buffer Gate with 3-state Output |
| SN74LV1T126 | DCK, DBV | Single Buffer Gate with 3-state Output |
| SN74LV4T125 | RGY, PW | Quadruple Bus Buffer Gate With 3-State Outputs |



6 Pin Configuration and Functions

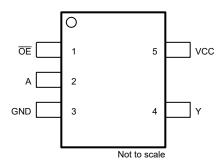


Figure 6-1. DCK or DBV Package, 5-Pin SC70 or SOT-23 (Top View)

Table 6-1. Pin Functions

| PIN NAME NO. | | TYPE(1) | DESCRIPTION | | | |
|-----------------|---|---------|---------------------------|--|--|--|
| | | ITPE\' | DESCRIPTION | | | |
| ŌĒ | 1 | I | Output enable, active low | | | |
| A 2 I | | I | Input A | | | |
| GND | 3 | G | Ground | | | |
| Υ | 4 | 0 | Output Y | | | |
| V _{CC} | 5 | Р | Positive supply | | | |

(1) I = Input, O = Output, I/O = Input or Output, G = Ground, P = Power.

7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

| | - | | MIN | MAX | UNIT |
|------------------|------------------------------------|--|------|-----------------------|------|
| V _{CC} | Supply voltage range | | -0.5 | 7.0 | V |
| VI | Input voltage range ⁽²⁾ | | -0.5 | 7.0 | V |
| Vo | Voltage range applied to a | any output in the high or low state ⁽²⁾ | -0.5 | V _{CC} + 0.5 | V |
| I _{IK} | Input clamp current | V _I < 0 | | -20 | mA |
| I _{OK} | Output clamp current | $V_O < 0$ or $V_O > V_{CC}$ | | ±20 | mA |
| Io | Continuous output current | t i | | ±25 | mA |
| | Continuous current throug | nh V _{CC} or GND | | ±50 | mA |
| TJ | Junction temperature | | | 150 | °C |
| T _{stg} | Storage temperature | | -65 | 150 | °C |

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

| | | | VALUE | UNIT |
|--------------------|-------------------------|---|-------|------|
| | | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾ | ±2000 | |
| V _(ESD) | Electrostatic discharge | Machine Model (MM), per JEDEC specification | ±200 | V |
| | | Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 ⁽²⁾ | ±1000 | |

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted) (1)

| | | | MIN | MAX | UNIT |
|-----------------|--------------------------------|----------------------------------|-----|-----------------|------|
| V _{CC} | Supply voltage | | 1.6 | 5.5 | V |
| VI | Input voltage | | 0 | 5.5 | V |
| Vo | Output voltage | | 0 | V _{CC} | V |
| Іон | | V _{CC} = 1.8 V | | -3 | |
| | High-level output current | V _{CC} = 2.5 V | | -5 | mA |
| | nigri-level output current | V _{CC} = 3.3 V | | -7 | ША |
| | | V _{CC} = 5.0 V | | -8 | |
| | | V _{CC} = 1.8 V | | 3 | |
| | Low-level output current | V _{CC} = 2.5 V | | 5 | mΛ |
| I _{OL} | | V _{CC} = 3.3 V | | 7 | mA |
| | | V _{CC} = 5.0 V | | 8 | |
| | | V _{CC} = 1.8 V | | 20 | |
| Δt/Δν | Low-level output current | V _{CC} = 3.3 V or 2.5 V | | 20 | ns/V |
| | | V _{CC} = 5.0 V | | 20 | |
| T _A | Operating free-air temperature | | -40 | 125 | °C |

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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⁽²⁾ The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



7.4 Thermal Information

| | THERMAL METRIC ⁽¹⁾ | DBV | DCK | UNIT |
|---|---|------|-------|------|
| | 5 PINS | UNIT | | |
| F | R _{0JA} Junction-to-ambient thermal resistance | 206 | 289.2 | °C/W |

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

7.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

| DADA | METER | TEST CONDITIONS | V | T _A = | T _A = 25°C | | T _A = -40°0 | C to +125° | С | UNIT |
|--|---------------------------|--|------------------------------------|-----------------------|-----------------------|------|------------------------|------------|-------|------|
| PARAMETER | | TEST CONDITIONS | V _{cc} | MIN | TYP | MAX | MIN | TYP | MAX | UNII |
| | | | V _{CC} = 1.65 V to 1.8 V | 0.95 | | | 1 | | | |
| | | | V _{CC} = 2.0 V | 0.99 | | | 1.03 | | | |
| √ _{IH} High-level input voltage | | V _{CC} = 2.25 V to 2.5 V | 1.145 | | | 1.18 | | | | |
| | High-level | | V _{CC} = 2.75 V | 1.22 | | | 1.25 | | | ., |
| | | | V _{CC} = 3 V to 3.3 V | 1.37 | | | 1.39 | | | V |
| | | | V _{CC} = 3.6 V | 1.47 | | | 1.48 | | | |
| | | | V _{CC} = 4.5 V to 5.0 V | 2.02 | | | 2.03 | | | |
| | | | V _{CC} = 5.5 V | 2.1 | | | 2.11 | | | |
| | | | V _{CC} = 1.65 V to 2.0 V | | | 0.57 | | | 0.55 | |
| , | Low-level | | V _{CC} = 2.25 V to 2.75 V | | | 0.75 | | | 0.71 | V |
| / _{IL} ir | nput voltage | | V _{CC} = 3 V to 3.6 V | | | 0.8 | | | 0.65 | V |
| | | | V _{CC} = 4.5 V to 5.5 V | | | 0.8 | | | 0.8 | |
| | | I _{OH} = -20 μA | 1.65 V to 5.5 V | V _{CC} - 0.1 | | | V _{CC} - 0.1 | | | |
| | | I - 0.0 A | 1.65 V | 1.28 | | | 1.21 | | | |
| | | $I_{OH} = -2.0 \text{ mA}$ | 1.8 V | 1.5 | | | 1.45 | | | |
| | High-level output | I _{OH} = -3 mA | 2.3 V | 2 | | | 1.93 | | | |
| - | | I _{OH} = -3 mA | 2.5 V | 2.25 | | | 2.15 | | | |
| / _{OH} o | | I _{OH} = -3.0 mA | 201/ | 2.78 | | | 2.7 | | | V |
| V | /oltage | I _{OH} = -5.5 mA | 3.0 V | 2.6 | | | 2.49 | | | |
| | | I _{OH} = -5.5 mA | 3.3 V | 2.9 | | | 2.8 | | | |
| | | I _{OH} = -4 mA | 4.5 V | 4.2 | | | 4.1 | | | |
| | | I _{OH} = -8 mA | 4.5 V | 4.1 | | | 3.95 | | | |
| | | I _{OH} = -8 mA | 5.0 V | 4.6 | | | 4.5 | | | |
| | | I _{OL} = 20 μA | 1.65 V to 5.5 V | | | 0.1 | | | 0.1 | |
| | | I _{OL} = 2 mA | 1.65 V | | | 0.2 | | | 0.25 | |
| 1 | _ow-level | I _{OL} = 3 mA | 2.3 V | | | 0.15 | | | 0.2 | |
| o _L o | output | I _{OL} = 3 mA | 3.0 V | | | 0.11 | | | 0.15 | V |
| V | /oltage | I _{OL} = 5.5 mA | 3.0 V | | | 0.21 | | | 0.252 | |
| | | I _{OL} = 4 mA | 451/ | | | 0.15 | | | 0.2 | |
| | | I _{OL} = 8 mA | 4.5 V | | | 0.3 | | | 0.35 | |
| ı le | nput eakage current | A input; V _I = 0 V or V _{CC} | 0 V, 1.8 V, 2.5 V, 3.3 V, 5.5 V | | | 0.1 | | | ±1 | μA |
| | | | 5.0 V | | | 1 | | | 10 | |
| S | Static supply | $V_I = 0 \text{ V or } V_{CC}$ | 3.3 V | | | 1 | | | 10 | |
| | current | I _O = 0; open on loading | 2.5 V | | | 1 | | | 10 | μA |
| | | | 1.8 V | | | 1 | | , | 10 | |

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over recommended operating free-air temperature range (unless otherwise noted)

| DAI | RAMETER | TEST CONDITIONS | V _{CC} | T _A = 2 | 5°C | | T _A = -40°0 | C to +125 | °C | UNIT |
|------------------|--------------------------|--|-----------------|--------------------|-----|------|------------------------|-----------|------|------|
| FAI | KAWEIEK | TEST CONDITIONS | V CC | MIN TYP MAX | | MIN | TYP | MAX | UNII | |
| ۸۱۰۰ | Additional static supply | One input at 0.3 V or 3.4 V, Other inputs at 0 or V _{CC} , I _O = 0 | 5.5 V | | | 1.35 | | | 1.5 | mA |
| ΔI _{CC} | current | One input at 0.3 V or 1.1 V Other inputs at 0 or V _{CC} , I _O = 0 | 1.8 V | | | 10 | | | 10 | μА |
| C _i | Input capacitance | V _I = V _{CC} or GND | 3.3 V | | 2 | 10 | 2 | 2 | 10 | pF |
| C _o | Output capacitance | V _O = V _{CC} or GND | 3.3 V | | 2.5 | | 2 | 2.5 | | pF |

7.6 Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

| PARAMETER | FROM | то | FREQUENCY | V | _ | TA | = 25°C | | $T_A = -65^{\circ}C$ to | 125°C | UNIT | | | | | | | | | | |
|-------------------------------------|--|----------|--|-------------------|----------------|-----------------|---------------|----------------|-------------------------|-------|-------|-----|-----|----------------|-------|-------|-----|-----|------|-----|------|
| PARAMETER | (INPUT) | (OUTPUT) | (TYP) | V _{CC} | CL | MIN | TYP | MAX | MIN TYP | MAX | UNII | | | | | | | | | | |
| | | | | 5.0 V | 15 pF | 2.7 5.5 | 3.4 | 6.5 | ns | | | | | | | | | | | | |
| | | | DC to 50 MHz | | 30 pF | | 3.0 | 6.5 | 4.1 | 7.5 | ns | | | | | | | | | | |
| | | | DC 10 30 Wil 12 | DO TO SO IVIAZ | DC 10 50 IVIHZ | DO TO JO IVITIZ | 3.3 V | 15 pF | | 4.0 | 7.0 | 5.0 | 8.0 | no | | | | | | | |
| + . | Any In | Y | | 3.3 V | 30 pF | | 4.9 | 8.0 | 6.0 | 9.0 | ns | | | | | | | | | | |
| t _{pd} | Any in | r | DC to 25 MHz | 2.5 V | 15 pF | | 5.8 | 8.5 | 6.8 | 9.5 | ne | | | | | | | | | | |
| | | | DC to 25 MHz | 2.5 V | 30 pF | | 6.5 | 9.5 | 7.5 | 10.5 | ns | | | | | | | | | | |
| | | | DC to 15 MHz | 1.8 V | 15 pF | | 10.5 | 13.0 | 11.8 | 14.0 | ns | | | | | | | | | | |
| | | | DC to 15 MHz | 1.0 V | 30 pF | | 12.0 | 14.5 | 12.0 | 15.5 | 115 | | | | | | | | | | |
| | | | | 5.0 V | 15 pF | | 3.0 | 5.0 | 3.5 | 6.0 | ns | | | | | | | | | | |
| | | | DC to 50 MHz | DC to 50 MHz | DC to 50 MHz | 5.0 V | 30 pF | | 4.3 | 6.5 | 4.9 | 7.5 | | | | | | | | | |
| | | | | 3.3 V | 15 pF | | 4.0 | 6.5 | 4.5 | 7.5 | no | | | | | | | | | | |
| t t | t _{PZH} , t _{PZL} OE Y | ΩF | l v | | 3.3 V | 30 pF | | 5.0 | 8.0 | 6.5 | 9.0 | ns | | | | | | | | | |
| ₽ZH, PZL | | T | DC to 25 MHz | 2.5 V | 15 pF | | 5.5 | 8.0 | 6.1 | 9.0 | ns | | | | | | | | | | |
| | | | | | | | | | | | | | | DC to 23 WI 12 | 2.5 V | 30 pF | | 7.0 | 10.0 | 8.5 | 11.0 |
| | | | DC to 15 MHz 1.8 V 15 pF 9.0 12.0 9.85 | 9.85 | 13.0 | ns | | | | | | | | | | | | | | | |
| | | | DC to 13 WHZ | 1.0 V | 30 pF | | 12.5 | 15.0 | 13.5 | 16.0 | 115 | | | | | | | | | | |
| | | | | 5.0 V | 15 pF | | 4.2 | 6.5 | 4.5 | 7.0 | ns | | | | | | | | | | |
| | | | DC to 50 MHz | J.0 V | 30 pF | | 4.8 | 8.0 | 5.0 | 8.5 | 115 | | | | | | | | | | |
| | | | DO 10 30 WI IZ | 3.3 V | 15 pF | | 4.5 | 7.0 | 5.0 | 8.0 | ns | | | | | | | | | | |
| t _{PHZ} , t _{PLZ} | OE | Y | | J.5 V | 30 pF | | 5.0 | 8.0 | 5.5 | 9.0 | 113 | | | | | | | | | | |
| ΨHZ, ΨLZ | JL JL | 1 | DC to 25MHz | 2.5 V | 15 pF | | 5.0 | 11.0 | 6.0 | 9.0 | ns | | | | | | | | | | |
| | | | DC to 25MHZ | DC to 25WHZ 2.5 V | DC to 25MHZ | DO TO 25IVIEZ | DO 10 25W1112 | 50 to 20101112 | DO to 25WI IZ | 2.5 V | 30 pF | | 6.0 | 9.0 | 7.0 | 10.0 | 115 | | | | |
| | | | DC to 15MHz | 1.8 V | 15 pF | | 8.0 | 10.0 | 8.5 | 11.0 | ns | | | | | | | | | | |
| | | | DO TO TOIVINZ | 1.0 V | 30 pF | | 8.5 | 11.0 | 9.5 | 12.0 | 115 | | | | | | | | | | |

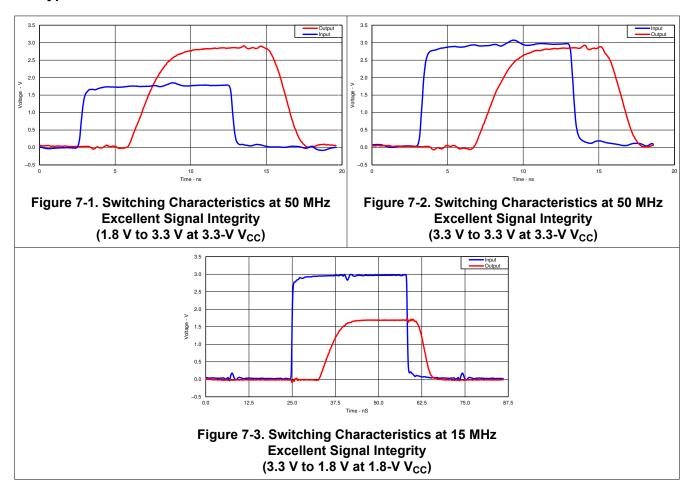
7.7 Operating Characteristics

 $T_A = 25^{\circ}C$

| PARAMETER | | TEST CONDITIONS | V _{cc} | TYP | UNIT |
|---|------|------------------------|-----------------|-----|------|
| C _{pd} Power dissipation capacitance | | | 1.8 V ± 0.15 V | 14 | |
| | unao | f = 1 MHz and 10 MHz | 2.5 V ± 0.2 V | 14 | |
| | ince | I - I WINZ AND TO WINZ | 3.3 V ± 0.3 V | | pF |
| | | | 5.5 V ± 0.5 V | 14 | |

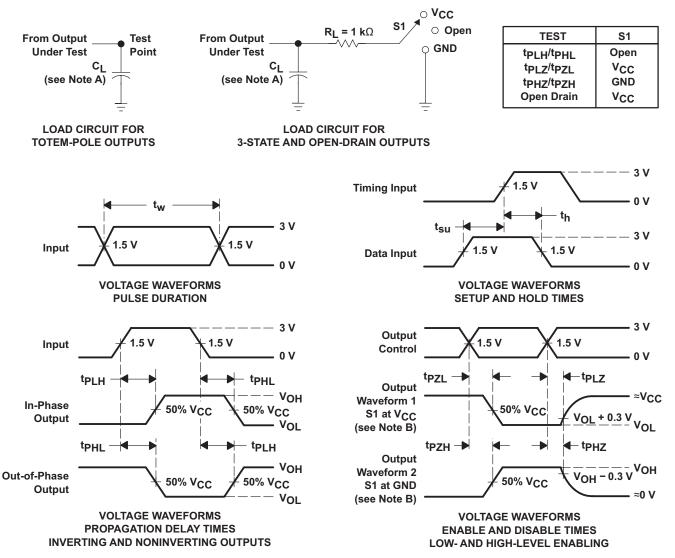


7.8 Typical Characteristics





8 Parameter Measurement Information



NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , $t_f \leq$ 3 ns. $t_f \leq$ 3 ns.
- D. The outputs are measured one at a time, with one input transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 8-1. Load Circuit and Voltage Waveforms

9 Detailed Description

9.1 Overview

The SN74LV1T125 device is a low-voltage CMOS gate logic that operates at a wider voltage range for industrial, portable, telecom, and automotive applications. The output level is referenced to the supply voltage and is able to support 1.8-V, 2.5-V, 3.3-V, and 5-V CMOS levels. The input is designed with a lower threshold circuit to match 1.8 V input logic at V_{CC} = 3.3 V and can be used in 1.8 V to 3.3 V level-up translation. In addition, the 5 V tolerant input pins enable down translation (that is, 3.3 V to 2.5 V output at V_{CC} = 2.5 V). The wide V_{CC} range of 1.8 V to 5.5 V allows generation of desired output levels to connect to controllers or processors. The SN74LV1T125 device is designed with current-drive capability of 8 mA to reduce line reflections, overshoot, and undershoot caused by high-drive outputs.

9.2 Functional Block Diagram

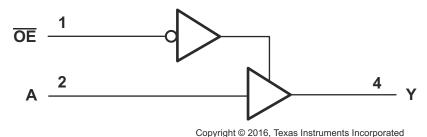


Figure 9-1. Logic Diagram

9.3 Feature Description

9.3.1 Clamp Diode Structure

The outputs to this device have both positive and negative clamping diodes, and the inputs to this device have negative clamping diodes only as depicted in Figure 9-2.

CAUTION

Voltages beyond the values specified in the Absolute Maximum Ratings table can cause damage to the device. The input and output voltage ratings may be exceeded if the input and output clampcurrent ratings are observed.

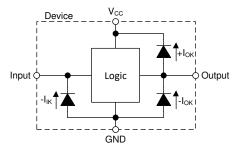


Figure 9-2. Electrical Placement of Clamping Diodes for Each Input and Output

9.3.2 Balanced CMOS Push-Pull Outputs

This device includes balanced CMOS push-pull outputs. The term balanced indicates that the device can sink and source similar currents. The drive capability of this device may create fast edges into light loads so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. It is important for the output power of the device to be limited to avoid damage due to overcurrent. The electrical and thermal limits defined in the Absolute Maximum Ratings must be followed at all times.

Product Folder Links: SN74LV1T125



Unused push-pull CMOS outputs should be left disconnected.

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9.3.3 LVxT Enhanced Input Voltage

The SN74LV1T125 belongs to TI's LVxT family of Logic devices with integrated voltage level translation. This family of devices was designed with reduced input voltage thresholds to support up-translation, and inputs tolerant of signals with up to 5.5 V levels to support down-translation. The output voltage will always be referenced to the supply voltage (V_{CC}), as described in the Electrical Characteristics table. To ensure proper functionality, input signals must remain at or below the specified $V_{\text{IH}(\text{MIN})}$ level for a HIGH input state, and at or below the specified V_{IL(MAX)} for a LOW input state. Figure 9-3 shows the typical V_{IH} and V_{IL} levels for the LVxT family of devices, as well as the voltage levels for standard CMOS devices for comparison.

The inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the Electrical Characteristics. The worst case resistance is calculated with the maximum input voltage, given in the Absolute Maximum Ratings, and the maximum input leakage current, given in the Electrical Characteristics, using Ohm's law (R = V ÷ I).

The inputs require that input signals transition between valid logic states quickly, as defined by the input transition time or rate in the Recommended Operating Conditions table. Failing to meet this specification will result in excessive power consumption and could cause oscillations. More details can be found in the Implications of Slow or Floating CMOS Inputs application report.

Do not leave inputs floating at any time during operation. Unused inputs must be terminated at V_{CC} or GND. If a system will not be actively driving an input at all times, a pull-up or pull-down resistor can be added to provide a valid input voltage during these times. The resistor value will depend on multiple factors; however, a 10-k Ω resistor is recommended and will typically meet all requirements.

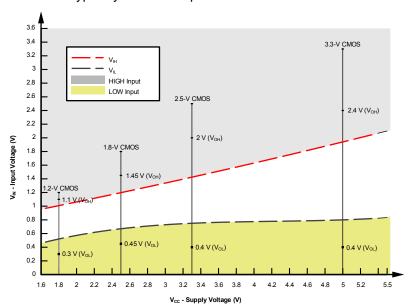


Figure 9-3. LVxT Input Voltage Levels

9.3.3.1 Down Translation

Signals can be translated down using the SN74LV1T125. The voltage applied at the V_{CC} will determine the output voltage and the input thresholds as described in the Recommended Operating Conditions and Electrical Characteristics tables.

When connected to a high-impedance input, the output voltage will be approximately V_{CC} in the HIGH state, and 0 V in the LOW state. Ensure that the input signals in the HIGH state are between $V_{\text{IH}(\text{MIN})}$ and 5.5 V, and input signals in the LOW state are lower than V_{IL(MAX)} as shown in Figure 9-3.

For example, standard CMOS inputs for devices operating at 5.0 V, 3.3 V or 2.5 V can be down-translated to match 1.8 V CMOS signals when operating from 1.8-V V_{CC}. See Figure 9-4.

Product Folder Links: SN74LV1T125

Down Translation Combinations:

- 1.8-V V_{CC} Inputs from 2.5 V, 3.3 V, and 5.0 V
- 2.5-V V_{CC} Inputs from 3.3 V and 5.0 V
- 3.3-V V_{CC} Inputs from 5.0 V

9.3.3.2 Up Translation

Input signals can be up translated using the SN74LV1T125. The voltage applied at V_{CC} will determine the output voltage and the input thresholds as described in the *Recommended Operating Conditions* and *Electrical Characteristics* tables. When connected to a high-impedance input, the output voltage will be approximately V_{CC} in the HIGH state, and 0 V in the LOW state.

The inputs have reduced thresholds that allow for input high-state levels which are much lower than standard values. For example, standard CMOS inputs for a device operating at a 5-V supply will have a $V_{IH(MIN)}$ of 3.5 V. For the SN74LV1T125, $V_{IH(MIN)}$ with a 5-V supply is only 2 V, which would allow for up-translation from a typical 2.5-V to 5-V signals.

Ensure that the input signals in the HIGH state are above $V_{IH(MIN)}$ and input signals in the LOW state are lower than $V_{IL(MAX)}$ as shown in Figure 9-4.

Up Translation Combinations:

- 1.8-V V_{CC} Inputs from 1.2 V
- 2.5-V V_{CC} Inputs from 1.8 V
- 3.3-V V_{CC} Inputs from 1.8 V and 2.5 V
- 5.0-V V_{CC} Inputs from 2.5 V and 3.3 V

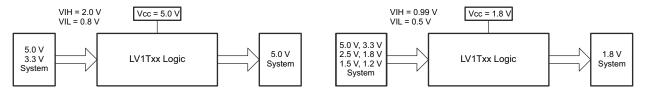


Figure 9-4. LVxT Up and Down Translation Example

9.4 Device Functional Modes

Function Tables

| INPUT (LOWER LEV | OUTPUT (2) (V _{CC} CMOS) | |
|---------------------|--------------------------------------|---|
| OE ⁽³⁾ | A | Υ |
| L | Н | Н |
| L | L | L |
| Н | Х | Z |

- (1) H = High Voltage Level, L = Low Voltage Level, X = Do not Care, Z = High Impedance
- (2) H = Driving High, L = Driving Low, Z = High Impedance State
- (3) Not recommend to float OE pin for signal oscillation.

| SUPPLY V _{CC} = 3.3 V | | | | | | | |
|--------------------------------|------------|------------------------|--|--|--|--|--|
| INF | PUT | OUTPUT | | | | | |
| (LOWER LE | VEL INPUT) | (V _{CC} CMOS) | | | | | |
| A | В | Y | | | | | |
| V _{IH} (min) | = 1.35 V | $V_{OH}(min) = 2.9 V$ | | | | | |
| V _{IL} (max) |) = 0.8 V | $V_{OL}(max) = 0.2 V$ | | | | | |

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10 Application Information Disclaimer

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

10.1 Layout

10.1.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or V_{CC}, whichever makes more sense for the logic function or is more convenient.

10.2 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. A 0.1- μ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1- μ F and 1- μ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results, as shown in the following layout example.

Product Folder Links: SN74LV1T125

11 Device and Documentation Support

11.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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11.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

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11.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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www.ti.com 27-Sep-2023

PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead finish/ Ball material | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|-------------------|--------|--------------|--------------------|------|----------------|--------------|-------------------------------|--------------------|--------------|-------------------------|---------|
| SN74LV1T125DBVR | ACTIVE | SOT-23 | DBV | 5 | 3000 | RoHS & Green | NIPDAU SN | Level-1-260C-UNLIM | -40 to 125 | (NEZ3, NEZJ, NEZS) | Samples |
| SN74LV1T125DBVRG4 | ACTIVE | SOT-23 | DBV | 5 | 3000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | NEZ3 | Samples |
| SN74LV1T125DCKR | ACTIVE | SC70 | DCK | 5 | 3000 | RoHS & Green | NIPDAU SN | Level-1-260C-UNLIM | -40 to 125 | (WZ3, WZJ, WZS) | Samples |
| SN74LV1T125DCKRG4 | ACTIVE | SC70 | DCK | 5 | 3000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | | WZ3 | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

www.ti.com 27-Sep-2023

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OTHER QUALIFIED VERSIONS OF SN74LV1T125:

Automotive: SN74LV1T125-Q1

NOTE: Qualified Version Definitions:

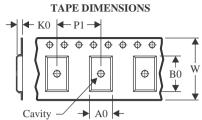
• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

PACKAGE MATERIALS INFORMATION

www.ti.com 5-Oct-2023

TAPE AND REEL INFORMATION





| A0 | Dimension designed to accommodate the component width |
|----|---|
| В0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

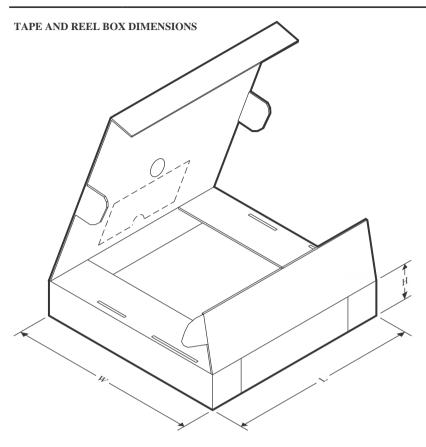


*All dimensions are nominal

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------------|-----------------|--------------------|---|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| SN74LV1T125DBVR | SOT-23 | DBV | 5 | 3000 | 178.0 | 9.0 | 3.3 | 3.2 | 1.4 | 4.0 | 8.0 | Q3 |
| SN74LV1T125DBVRG4 | SOT-23 | DBV | 5 | 3000 | 178.0 | 9.2 | 3.3 | 3.23 | 1.55 | 4.0 | 8.0 | Q3 |
| SN74LV1T125DCKR | SC70 | DCK | 5 | 3000 | 178.0 | 9.0 | 2.4 | 2.5 | 1.2 | 4.0 | 8.0 | Q3 |
| SN74LV1T125DCKR | SC70 | DCK | 5 | 3000 | 180.0 | 8.4 | 2.47 | 2.3 | 1.25 | 4.0 | 8.0 | Q3 |
| SN74LV1T125DCKRG4 | SC70 | DCK | 5 | 3000 | 178.0 | 9.2 | 2.4 | 2.4 | 1.22 | 4.0 | 8.0 | Q3 |

PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

| 7 till dillitoriolionio di o mominidi | | | | | | | |
|---------------------------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| SN74LV1T125DBVR | SOT-23 | DBV | 5 | 3000 | 180.0 | 180.0 | 18.0 |
| SN74LV1T125DBVRG4 | SOT-23 | DBV | 5 | 3000 | 180.0 | 180.0 | 18.0 |
| SN74LV1T125DCKR | SC70 | DCK | 5 | 3000 | 180.0 | 180.0 | 18.0 |
| SN74LV1T125DCKR | SC70 | DCK | 5 | 3000 | 202.0 | 201.0 | 28.0 |
| SN74LV1T125DCKRG4 | SC70 | DCK | 5 | 3000 | 180.0 | 180.0 | 18.0 |





NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
 3. Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. Reference JEDEC MO-203.

- 4. Support pin may differ or may not be present.





NOTES: (continued)

4. Publication IPC-7351 may have alternate designs.5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 7. Board assembly site may have different recommendations for stencil design.



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